

Laboratory

Nishitronics Instrumentation, Flat No. 1 & 5, Plot No. 113, Servey No. 635/642, Gurukrupa Building Mahesh Co. Op. Housing Soc. Bibwewadi, Pune, Maharashtra

Accreditation Standard ISO/IEC 17025: 2005

Certificate Number

CC-2294

Page

1 of 11

Validity

14.06.2018 to 13.06.2020

Last Amended on -

Sl.	Quantity Measured / Instrument	Range/Frequency	*Calibration Measurement Capability (\pm)	Remarks
<u>ELECTRO-TECHNICAL CALIBRATION</u>				
I.	SOURCE			
1.	DC Voltage [#]	1 mV to 20 mV 20 mV to 200 mV 200 mV to 1000 V	0.475 % to 0.029 % 0.029 % to 0.008 % 0.008 % to 0.10 %	Using Multifunction Calibrator By Direct Method
2.	DC Current [#]	20 μ A to 200 μ A 200 μ A to 200 mA 200 mA to 20 A 20 A to 1000 A	0.166 % to 0.032 % 0.032 % to 0.019 % 0.019 % to 0.094 % 0.58 %	Using Multifunction Calibrator By Direct Method Using Multifunction Calibrator With Turn Coil
3.	AC Voltage [#]	@50 Hz to 1 kHz 10 mV to 200 mV 200 mV to 20 V 20 V to 1000 V	1.22 % to 0.14 % 0.14 % to 0.089 % 0.089 % to 0.12 %	Using Multifunction Calibrator By Direct Method
4.	AC Current [#]	@50 Hz to 1 kHz 20 μ A to 200 mA 200 mA to 20 A @50 Hz to 500 Hz 20 A to 1000 A	1.84 % to 0.113 % 0.113 % to 0.267 % 0.64 %	Using Multifunction Calibrator By Direct Method Using Multifunction Calibrator with Turn Coil

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Page

2 of 11

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5.	Resistance [#] 2 Wire	10 Ω to 100 k Ω 100 k Ω to 100 M Ω (In Discrete Decade Values) 40 Ω to 40 k Ω	0.114 % to 0.0174 % 0.0174 % to 1.2 % 0.202 % to 0.038 %	Using Multifunction Calibrator By Direct Method
6.	Frequency [#]	10 Hz to 10 MHz	0.07 % to 0.0024 %	Using Multifunction Calibrator By Direct Method
7.	Capacitance [#]	@ 1 kHz 10 nF to 1 μ F	0.58 % to 0.29 %	Using Multifunction Calibrator By Direct Method
8.	Period [#]	100 ns to 1s	0.0023 %	Using Multifunction Calibrator By Direct Method
9.	AC Power/ AC Energy [#] 1 \emptyset & 3 \emptyset Active / Reactive/ Apperent With Cos \emptyset \pm 0.1 to 1	@ 50 Hz 0.2 W to 115.2 kW (40 to 320 V & 50 mA to 120 A) Cos \emptyset \pm 0.1 to 1	0.31 % to 0.058 %	Using 3 Phase Reference Standard Calmet C300B By Direct Method
10.	Harmonics in Voltage & Current [#] Up to 39 Order	@ 50 Hz 250 V & 5 A (1 % to 40 %)	0.8 %	Using 3 Phase Reference Standard Calmet C300B By Direct Method
11.	CT Ratio [#]	1 A to 1000 A/ 5 mA to 5 A Ratio Phase	0.33 % 0.12 $^\circ$	Using 3 Phase Reference Standard Calmet C300B By Direct Method

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Accreditation Standard ISO/IEC 17025: 2005

Certificate Number

CC-2294

Page

3 of 11

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12.	Temperature Simulation [#] (Temperature Indicator)			
	RTD	(-) 100 °C to 800 °C	0.29 °C to 1.2 °C	Using Multifunction Calibrator By Direct Method
	K Type	(-) 200 °C to 1350 °C	0.29 °C	
	J Type	(-) 200 °C to 1200 °C	0.23 °C	
	T Type	(-) 200 °C to 400 °C	0.23 °C	
	R Type	50 °C to 1700 °C	1.15 °C	
	S Type	50 °C to 1700 °C	1.04 °C	
	B Type	600 °C to 1800 °C	1.73 °C	
	E Type	(-) 200 °C to 1000 °C	0.23 °C	
	N Type	(-) 200 °C to 1200 °C	0.46 °C	
II.	MEASURE			
1.	DC Voltage [#]	1 mV to 100 mV 100 mV to 10 V 10 V to 1000 V	0.093 % to 0.0025 % 0.0025 % to 0.006 % 0.006 % to 0.0025 %	Using Agilent 3458A By Direct/Comparison Method
2.	DC High Voltage*	1 kV to 30 kV	3.0 %	Using H.V. Probe With DMM
3.	DC Current [#]	100 nA to 1 μ A 1 μ A to 100 μ A 100 μ A to 10 mA 10 mA to 100 mA 100 mA to 1 A 1 A to 20 A	0.63 % to 0.7 % 0.7 % to 0.013 % 0.013 % to 0.007 % 0.007 % to 0.0088 % 0.0088 % to 0.019 % 0.25 %	Using Agilent 3458A with Current Shunt By Direct/Comparison Method

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Certificate Number

CC-2294

Page

4 of 11

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4.	AC Voltage [#]	50 Hz to 10 kHz 1 mV to 100 mV 100 mV to 10 V 10 V to 100 V 100 V to 700 V 10 kHz to 100 kHz 1 mV to 100 mV 100 mV to 10 V	0.37 % to 0.014 % 0.014 % 0.014 % to 0.027 % 0.027 % to 0.074 % 0.77 % to 0.097 % 0.097 %	Using Agilent 3458A By Direct/Comparison Method
5.	AC High Voltage*	1 kV to 30 kV	3.0 %	Using HV Probe with DMM by Direct Method
6.	AC Current [#]	50 Hz to 10 kHz 10 μ A to 100 μ A 100 μ A to 100 mA 100 mA to 1 A 50 Hz to 5 kHz 1 A to 20 A	0.43 % to 0.11 % 0.11 % to 0.099 % 0.099 % to 0.147 % 0.26 %	Using Agilent 3458A with current shunt By Direct/Comparison Method
7.	Resistance [#] (2 Wire)	100 Ω to 1 M Ω 1 M Ω to 100 M Ω 100 M Ω to 1 G Ω	0.062 % to 0.004 % 0.004 % to 0.12 % 0.12 % to 1.34 %	Using Agilent 3458A By Direct/Comparison Method
8.	Frequency [#]	1 Hz to 10 MHz	0.074 % to 0.11 %	Using Agilent 3458A By Direct/Comparison Method
9.	Period [#]	10 ns to 1 s	0.012 % to 0.058 %	Using 8½ DMM By Direct/Comparison Method
10.	Time [#] (Stop Watch)	6 sec to 60 min	0.2 to 2s	Using Stop watch By Comparison Method

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Certificate Number

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Page

5 of 11

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14.06.2018 to 13.06.2020

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11.	Temperature Simulation [#] Process Calibrator/ Recorder/Controller			Using Agilent 3458A By Direct/Comparison Method
	RTD/PRT	(-) 200 °C to 850 °C	0.023 °C	
	K Type	(-) 200 °C to 1370 °C	0.048 °C	
	J Type	(-) 200 °C to 1200 °C	0.042 °C	
	T Type	(-) 200 °C to 400 °C	0.041 °C	
	R Type	150 °C to 1700 °C	0.13 °C	
	S Type	150 °C to 1700 °C	0.16 °C	
	B Type	600 °C to 1800 °C	0.14 °C	
	E Type	(-) 200 °C to 1000 °C	0.037 °C	
	N Type	(-) 200 °C to 1300 °C	0.058 °C	

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Certificate Number

CC-2294

Page

6 of 11

Validity

14.06.2018 to 13.06.2020

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<u>MECHANICAL CALIBRATION</u>				
1.	PRESSURE INDICATING DEVICES			
1.	Pressure Pneumatic (Pressure Gauges/ Indicators, Pressure Transmitter, Pressure Switch) [#]	0 to 2 bar 0 to 16 bar	0.0005 bar 0.0025 bar	Using Wika Process Calibrator CPH 6000, Digital Test Gauge & Test Comparator Pumps By Comparison Method
2.	Pressure Hydraulic (Pressure Gauges/ Indicators, Pressure Transmitter, Pressure Switch) [#]	0 to 40 bar 0 to 250 bar 0 to 1000 bar	0.0055 bar 0.03 bar 0.1 bar	Using Wika Process Calibrator CPH 6000, Digital Test Gauge & Test Comparator Pumps By Comparison Method
3.	Vacuum (Vacuum Gauges/ Indicators, Vacuum Transmitters, Switch) [#]	(-) 0.85 bar to 0 bar	0.00044 bar	Using Wika Process Calibrator & Vacuum Test Comparator Pumps By Comparison Method
4.	Speed [#] (Non Contact) RPM, Tachometer & Rpm Generator	100 RPM to 20000 RPM 20000 RPM to 40000 RPM 40000 RPM to 90000 RPM	4 rpm 30 rpm 120 rpm	Using Tachometer with Techo generator By Comparison Method
5.	Speed [#] (Contact) RPM, Tachometer & Rpm Generator	100 RPM to 5000 RPM	4.5 rpm	By Direct Using Tachometer with Techo Generator By Comparison Method

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Accreditation Standard ISO/IEC 17025: 2005

Certificate Number

CC-2294

Page 7 of 11

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14.06.2018 to 13.06.2020

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II.	ACOUSTICS			
1.	Sound Level Meter ^s	94 dB & 114 dB	0.5 dB	Using Sound Level Calibrator By Comparison Method
III.	WEIGHTS			
1.	Mass ^s	1 mg 2 mg 5 mg 10 mg 20 mg 50 mg 100 mg 200 mg 500 mg 1 g 2 g 5 g 10 g 20 g 50 g 100 g 200 g 500 g 1 kg 2 kg	0.01 mg 0.01 mg 0.01 mg 0.01 mg 0.01 mg 0.02 mg 0.02 mg 0.02 mg 0.02 mg 0.03 mg 0.04 mg 0.05 mg 0.09 mg 0.09 mg 0.09 mg 0.13 mg 0.2 mg 3 mg 5 mg 10 mg	Using E1 Class Standard Weights and Mass Comparator / Precision Weighing Balance Readability: 0.01mg Calibration of weights of Class F1 accuracy and coarser as per OIML R-111 Using E1 Class Standard Weights and Mass Comparator / Precision Weighing Balance Readability: 1mg & 10mg Calibration of weights of Class F2 accuracy and coarser as per OIML R-111

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Accreditation Standard ISO/IEC 17025: 2005

Certificate Number CC-2294

Page 8 of 11

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		5 kg 10 kg 20 kg	100 mg 200 mg 200 mg	Using F1 Class Standard Weights and Mass Comparator / Precision Weighing Balance Readability: 100mg Calibration of weights of Class M1 accuracy and coarser as per OIML R-111
2.	Mass – Analogue / Electronic Weighing Balance # Readability: 0.001 mg, 0.01mg , 0.1 mg	Up to 60 g Up to 500 g	0.02 mg 0.2 mg	Using Weights of Accuracy class E1 Calibration of Electronic / Analytical Weighing Balance of Class I and coarser As per OIML R-76-1
3.	Mass – Analogue / Electronic Weighing Balance # Readability: 0.001 g 0.01 g 1.0 g	Up to 1kg Up to 5 kg Up to 50 kg	10 mg 15 mg 5 g	Using Weights of Accuracy class F1 Calibration of Electronic/ Analytical Weighing Balance of Class II and coarser As per OIML R-76-1
IV.	VOLUME			
1.	Volume ^s Pipette (@ 27° C)	10 μ l to 1000 μ l	0.1 μ l	Using standard weights E1 class ,Precision Balances L.C 0.01mg, Triple filter distilled ISO 8655 part 6

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Certificate Number CC-2294

Page 9 of 11

Validity 14.06.2018 to 13.06.2020

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2.	Glass ware ^s (Volumetric Apparatus Flasks, Burette, Pipette, Measuring Cylinder) (@ 27°C)	@27°C 1 ml to 100 ml > 100 ml to 1000 ml > 1000 ml to 2 l > 2000 ml to 5 l	0.006 μ l 0.035 μ l 5.0 μ l 6 ml	Using standard weights E-1&F1 class, Precision Balances L.C 0.01mg,0.1 mg & 1mg, Triple filter distilled water Gravimetric Method based on ISO 4787

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Certificate Number

CC-2294

Page

10 of 11

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14.06.2018 to 13.06.2020

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<u>THERMAL CALIBRATION</u>				
I.	TEMPERATURE			
1.	RTD / T/C with & without Indicator, Temperature Measuring Device with probe, Temp Gauge, Dig. Thermometer, Temp. Transmitter [#]	(-) 38 °C to 60 °C 60 °C to 650 °C 650 °C to 1000 °C 1000 °C to 1200 °C	0.05 °C 0.08 °C 2.43 °C 2.72 °C	Using Standard SSPRT, R Type T/C with 6½ DMM, Fluke DAQ STAQ, Liquid Baths, Dry Well Baths & dry well Furnace By Comparison Method
2.	Infrared/Pyrometers [#]	150 °C to 1200 °C	3 °C	Using Standard R Type T/C with 6 ½ DMM, Blackbody Furnace By Comparison Method
3.	Glass Thermometer [#] L.C.: 0.1 °C	(-) 38 °C to 60 °C 60 °C to 250 °C	0.12 °C	Using Standard SSPRT, 6 ½ DMM , Fluke DAQ STAQ & Liquid Bath By Comparison Method
	L.C.: 1 °C	(-) 38 °C to 60 °C 60 °C to 250 °C	0.6 °C	
4.	Liquid Baths [#]	(-) 30 °C to 250 °C	0.12 °C	Using Standard SSPRT with 6½ DMM By Mapping Method Based on Euramet cg13 & TRMH
5.	Dry Well Baths [#]	(-) 30 °C to 650 °C 650 °C to 1000 °C	0.2 °C 2.43 °C	Using Standard SSPRT, R Type T/C With 6½ DMM & Fluke DAQ STAQ By Mapping Method Based On Euramet CG13

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Certificate Number CC-2294

Page 11 of 11

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6.	Furnace*	300 °C to 1000 °C	4.0 °C	Using Single & Multipoint Standard SSPRT, T/C, 6½ DMM (Data Logger) & Fluke DAQ STAQ By Spatial Mapping Method
7.	Thermal/ Climatic Chambers, Hot Air Ovens, Autoclave, Indicators*	(-) 38 °C to 60 °C 60 °C to 300 °C	0.5 °C 1.5 °C	Using Single & Multi Point SSPRT, T/C With Fluke DAQ STAQ & 6½ DMM (Data Logger) By Mapping Method
II. SPECIFIC HEAT & HUMIDITY				
1.	Relative Humidity Meters, Digital & Analog Hygrometers RH Sensors, Temp/RH Data Logger#	5 °C to 50 °C 20 % RH to 95 % RH @ 25 \pm 4 °C	0.3 °C 1.8 % RH	Using Standard SSPRT With 6½ DMM, Fluke DAQ STAQ & Thermal Chamber Using Standard RH Sensor with Indicator and Humidity Generator By Comparison Method
2.	Thermal/ Climatic Chambers*	15 % RH to 95 % RH	3.25 % RH	Using Single & Multipoint Standard RH Sensor with Data Logger & RH Data Logger By Spatial Mapping Method

* Measurement Capability is expressed as an uncertainty (\pm) at a confidence probability of 95%

§ Only in Permanent Laboratory

* Only for Site Calibration

The laboratory is also capable for site calibration however, the uncertainty at site depends on the prevailing actual environmental conditions and master equipment used.

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